

Notice of References Cited		Application/Control No. 09/747,770	Applicant(s)/Patent Under Reexamination VANDERGEEST ET AL.	
		Examiner BENJAMIN E. LANIER	Art Unit 2132	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,078,908	06-2000	Schmitz, Kim	705/50
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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